

CoolSiC™
400V CoolSiC™ G2 MOSFET

PG-T0263-7

Features

- Ideal for high frequency switching and synchronous rectification
- Commutation robust fast body diode with low Q_{fr}
- Low $R_{DS(on)}$ dependency on temperature
- Benchmark gate threshold voltage, $V_{GS(th)} = 4.5\text{ V}$
- Recommended gate driving voltage 0 V to 18 V
- .XT interconnection technology for best-in-class thermal performance
- 100% avalanche tested

Potential applications

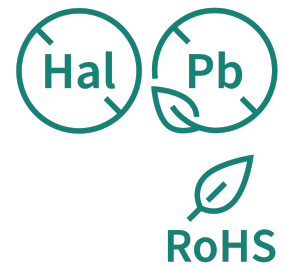
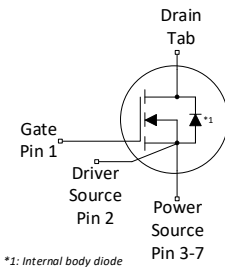
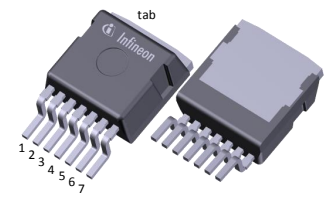
- SMPS
- Solar PV inverters
- Energy storage, UPS and battery formation
- Class-D audio
- Motor drives

Product validation

Fully qualified according to JEDEC for Industrial Applications

Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DS}	400	V
$R_{DS(on),typ}$	36.4	mΩ
I_D	50	A
Q_{oss}	42	nC
E_{oss}	3.0	μJ
Q_G	26	nC



Type/Ordering Code	Package	Marking	Related Links
IMBG40R036M2H	PG-T0263-7	40R036M2	-



Table of Contents

Description	1
Maximum ratings	3
Thermal characteristics	4
Operating range	4
Electrical characteristics	5
Electrical characteristics diagrams	7
Test Circuits	13
Package Outlines	14
Revision History	15
Trademarks	15
Disclaimer	15

1 Maximum ratings

at $T_A=25\text{ °C}$, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Continuous drain current ¹⁾	I_D	-	-	50 36 7.6	A	$V_{GS}=18\text{ V}$, $T_C=25\text{ °C}$ $V_{GS}=18\text{ V}$, $T_C=100\text{ °C}$ $V_{GS}=18\text{ V}$, $T_A=25\text{ °C}$, $R_{THJA}=40\text{ °C/W}^2)$
Pulsed drain current ³⁾	$I_{D,pulse}$	-	-	150	A	$T_C=25\text{ °C}$
Avalanche energy, single pulse ⁴⁾	E_{AS}	-	-	66	mJ	$I_D=11.1\text{ A}$, $R_{GS}=25\text{ }\Omega$
Avalanche energy, repetitive	E_{AR}	-	-	0.33	mJ	$I_D=11.1\text{ A}$, $R_{GS}=25\text{ }\Omega$
Gate source voltage (static)	$V_{GS,DC}$	-7	-	23	V	-
Gate source voltage (transient)	$V_{GS,AC}$	-10	-	25	V	$t_{pulse} \leq 500\text{ ns}$, duty cycle $\leq 1\%$
Power dissipation	P_{tot}	-	-	167 3.8	W	$T_C=25\text{ °C}$ $T_A=25\text{ °C}$, $R_{THJA}=40\text{ °C/W}^2)$
Storage temperature	T_{stg}	-55	-	150	°C	-
Operating junction temperature	T_j	-55	-	175	°C	-

¹⁾ Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See Diagram 3 for more detailed information.

⁴⁾ See Diagram 19 for more detailed information.

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	0.9	°C/W	-
Thermal resistance, junction - ambient, 6 cm ² cooling area ⁵⁾	R_{thJA}	-	-	40	°C/W	-

⁵⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

3 Operating range

Table 4 Operating range

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Recommended turn-on voltage	$V_{GS(on)}$	-	18	-	V	-
Recommended turn-off voltage	$V_{GS(off)}$	-	0	-	V	-

4 Electrical characteristics

at $T_j=25\text{ °C}$, unless otherwise specified

Table 5 Static characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	400	-	-	V	$V_{GS}=0\text{ V}$, $I_D=0.4\text{ mA}$
Gate threshold voltage ⁶⁾	$V_{GS(th)}$	3.5	4.5	5.6	V	$V_{DS}=V_{GS}$, $I_D=4\text{ mA}$
Zero gate voltage drain current	I_{DSS}	-	1 2	75 -	μA	$V_{DS}=400\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ °C}$ $V_{DS}=400\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=175\text{ °C}$
Gate-source leakage current	I_{GSS}	-	1	100	nA	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	36.4 52.5 44.6	45.7 - -	m Ω	$V_{GS}=18\text{ V}$, $I_D=11.1\text{ A}$, $T_j=25\text{ °C}$ $V_{GS}=18\text{ V}$, $I_D=11.1\text{ A}$, $T_j=175\text{ °C}$ $V_{GS}=15\text{ V}$, $I_D=11.1\text{ A}$, $T_j=25\text{ °C}$
Gate resistance	R_G	-	5.5	8.3	Ω	-

⁶⁾ Tested after 1ms pulse at $V_{GS} = +20\text{V}$.

Table 6 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	870	1170	pF	$V_{GS}=0\text{ V}$, $V_{DS}=200\text{ V}$, $f=1\text{ MHz}$
Output capacitance	C_{oss}	-	120	-	pF	$V_{GS}=0\text{ V}$, $V_{DS}=200\text{ V}$, $f=1\text{ MHz}$
Reverse transfer capacitance	C_{rss}	-	10	-	pF	$V_{GS}=0\text{ V}$, $V_{DS}=200\text{ V}$, $f=1\text{ MHz}$
Effective output capacitance, energy related ⁷⁾	$C_{o(er)}$	-	150	-	pF	$V_{GS}=0\text{ V}$, $V_{DS}=0\dots200\text{ V}$
Effective output capacitance, time related ⁸⁾	$C_{o(tr)}$	-	210	-	pF	$I_D=\text{constant}$, $V_{GS}=0\text{ V}$, $V_{DS}=0\dots200\text{ V}$
Turn-on delay time ⁹⁾	$t_{d(on)}$	-	13.0	-	ns	$V_{DD}=200\text{ V}$, $V_{GS}=0\dots18\text{ V}$, $I_D=11.1\text{ A}$, $R_{G,ext}=1.8\text{ }\Omega$
Rise time ⁹⁾	t_r	-	11.9	-	ns	$V_{DD}=200\text{ V}$, $V_{GS}=0\dots18\text{ V}$, $I_D=11.1\text{ A}$, $R_{G,ext}=1.8\text{ }\Omega$
Turn-off delay time ⁹⁾	$t_{d(off)}$	-	17.9	-	ns	$V_{DD}=200\text{ V}$, $V_{GS}=18\dots0\text{ V}$, $I_D=11.1\text{ A}$, $R_{G,ext}=1.8\text{ }\Omega$
Fall time ⁹⁾	t_f	-	8.1	-	ns	$V_{DD}=200\text{ V}$, $V_{GS}=18\dots0\text{ V}$, $I_D=11.1\text{ A}$, $R_{G,ext}=1.8\text{ }\Omega$

⁷⁾ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 200 V.

⁸⁾ $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 200 V.

⁹⁾ Refer to Table 9 for test setup.

Table 7 Gate Charge Characteristics ¹⁰⁾

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	7	-	nC	$V_{DD}=200\text{ V}$, $I_D=11.1\text{ A}$, $V_{GS}=0\text{ to }18\text{ V}$
Gate to drain charge	Q_{gd}	-	5.4	-	nC	$V_{DD}=200\text{ V}$, $I_D=11.1\text{ A}$, $V_{GS}=0\text{ to }18\text{ V}$
Gate charge total	Q_g	-	26	-	nC	$V_{DD}=200\text{ V}$, $I_D=11.1\text{ A}$, $V_{GS}=0\text{ to }18\text{ V}$
Gate charge total, sync. FET	$Q_{g(sync)}$	-	24	-	nC	$V_{DS}=0.1\text{ V}$, $V_{GS}=0\text{ to }18\text{ V}$
Output charge	Q_{oss}	-	42	-	nC	$V_{DS}=200\text{ V}$, $V_{GS}=0\text{ V}$
Output Energy	E_{oss}	-	3.0	-	μJ	$V_{DS}=200\text{ V}$, $V_{GS}=0\text{ V}$

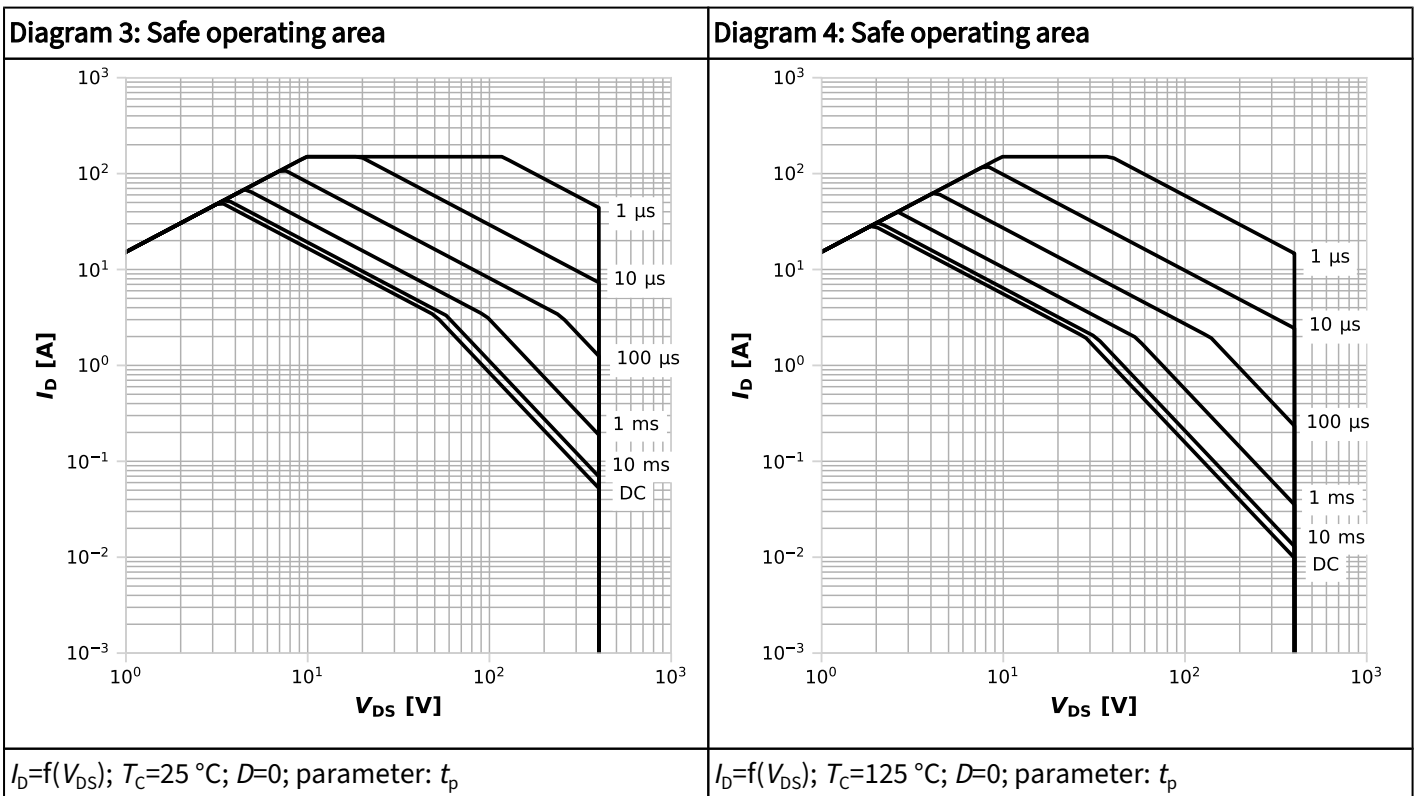
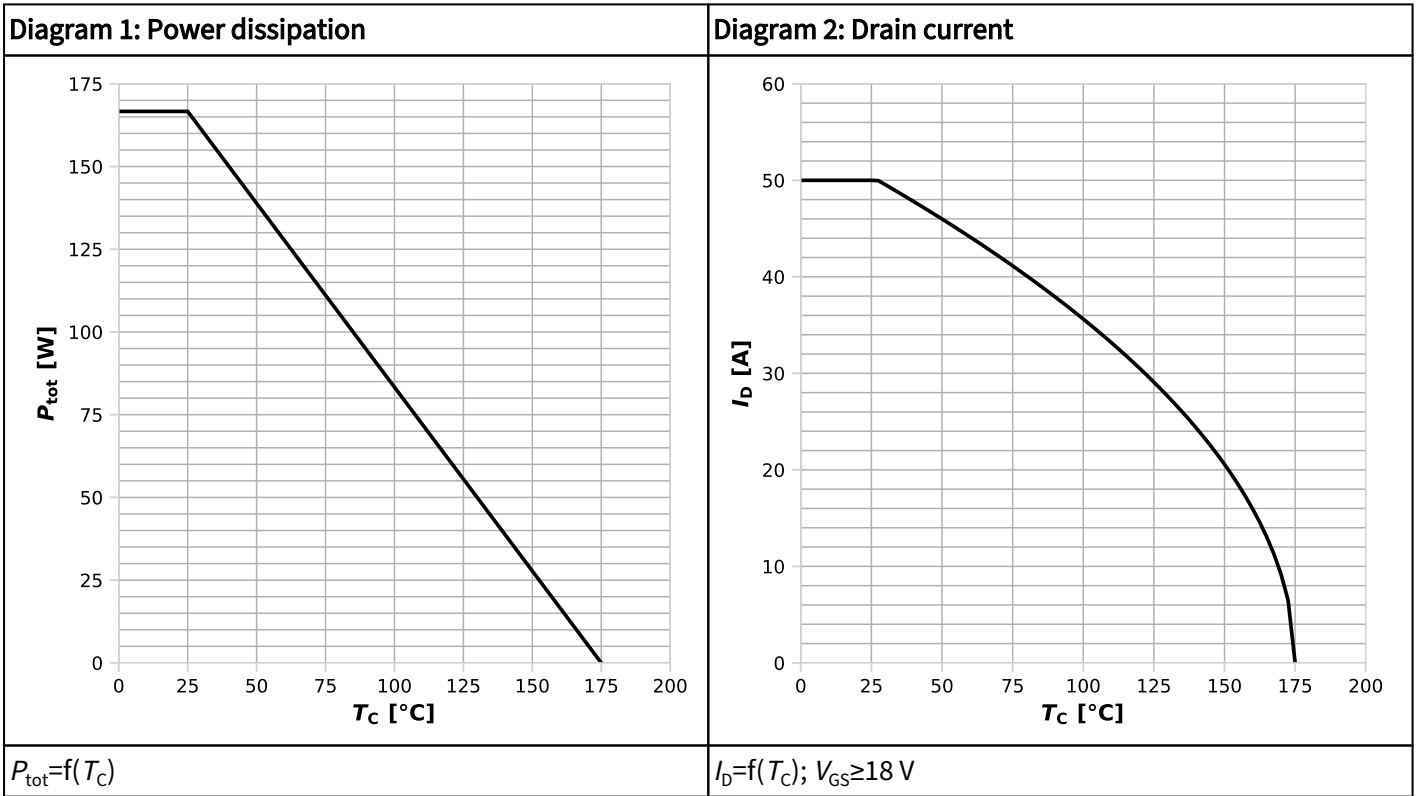
¹⁰⁾ As per JEP192, Guidelines for Gate Charge (Q_g) Test Method for SiC MOSFET.

Table 8 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	I_S	-	-	24	A	$T_c=25\text{ °C}$
Diode pulse current	$I_{S,pulse}$	-	-	150	A	$T_c=25\text{ °C}$, $t_{pulse} \leq 250\text{ ns}$
Diode forward voltage	V_{SD}	-	3.5	4.3	V	$V_{GS}=0\text{ V}$, $I_S=11.1\text{ A}$, $T_j=25\text{ °C}$
MOSFET forward recovery time	t_{fr}	-	11.5 8.5	-	ns	$V_R=200\text{ V}$, $I_S=11.1\text{ A}$, $di_S/dt=1000\text{ A}/\mu\text{s}$ $V_R=200\text{ V}$, $I_S=11.1\text{ A}$, $di_S/dt=3000\text{ A}/\mu\text{s}$
MOSFET forward recovery charge ¹¹⁾	Q_{fr}	-	39 77	-	nC	$V_R=200\text{ V}$, $I_S=11.1\text{ A}$, $di_S/dt=1000\text{ A}/\mu\text{s}$ $V_R=200\text{ V}$, $I_S=11.1\text{ A}$, $di_S/dt=3000\text{ A}/\mu\text{s}$

¹¹⁾ Q_{fr} includes Q_{oss} . Refer to Table 10 for test setup.

5 Electrical characteristics diagrams



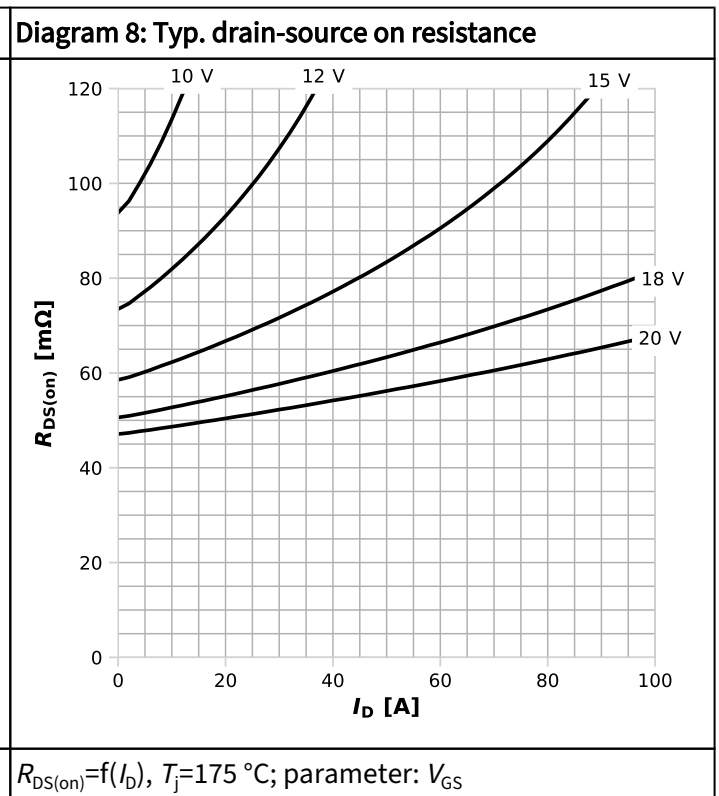
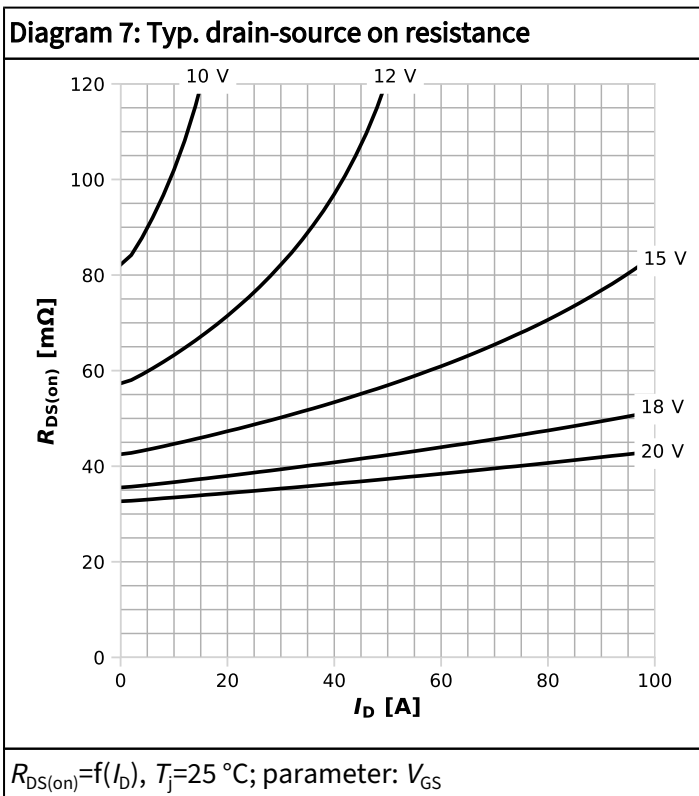
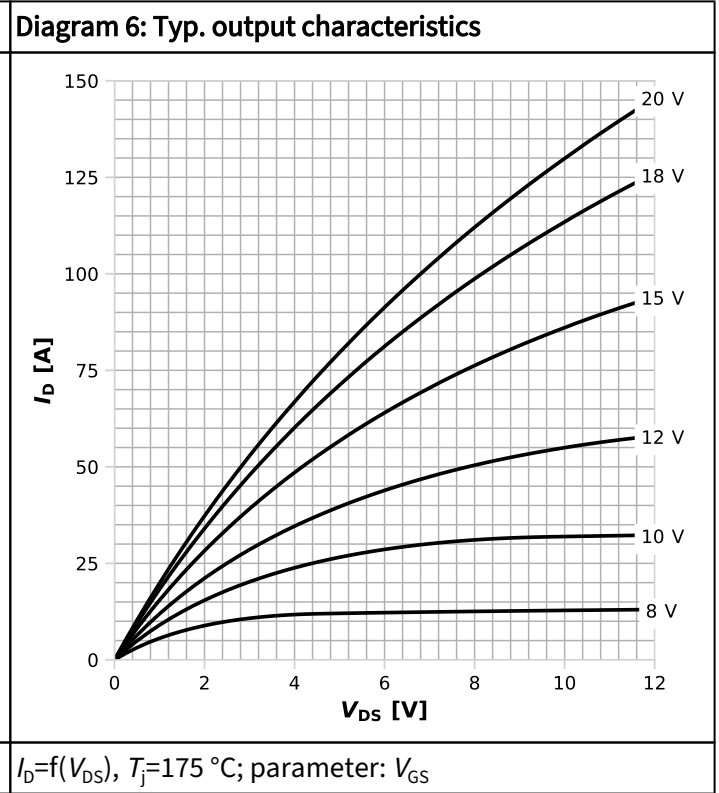
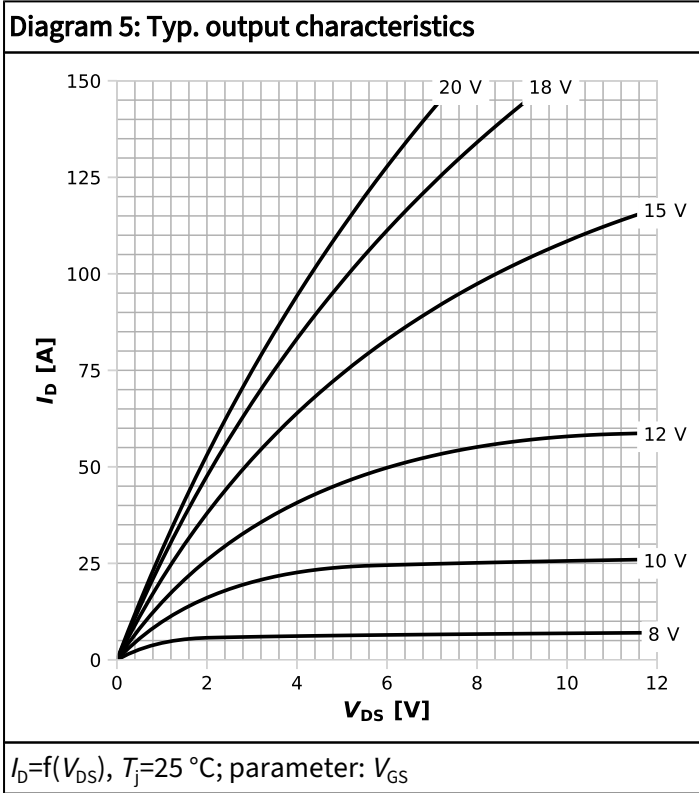
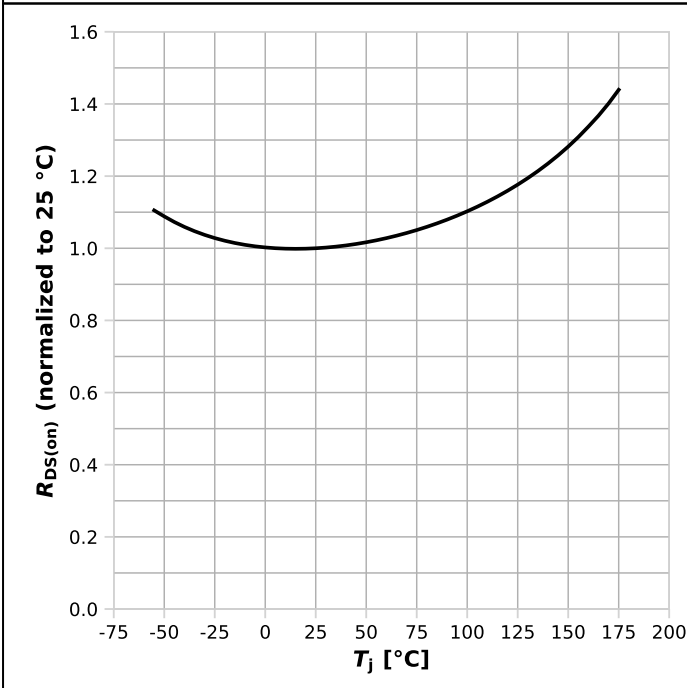
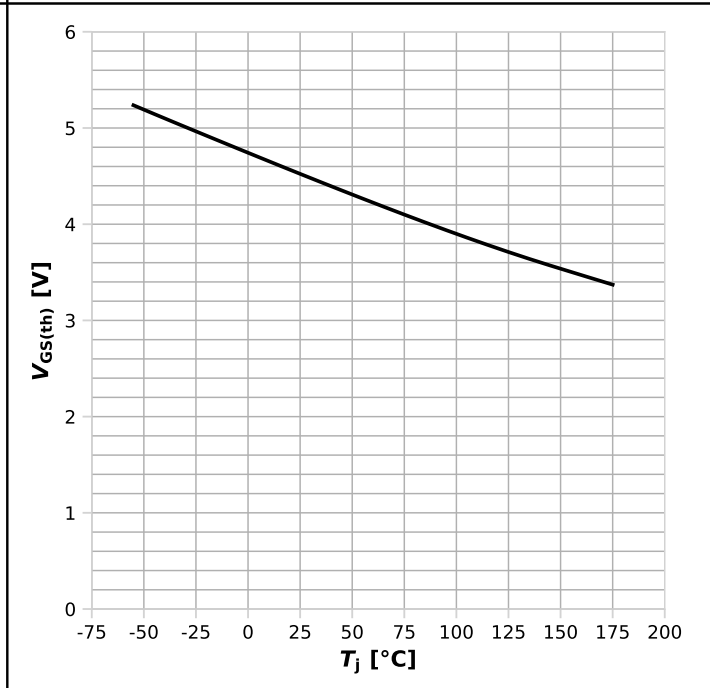


Diagram 9: Normalized drain-source on resistance



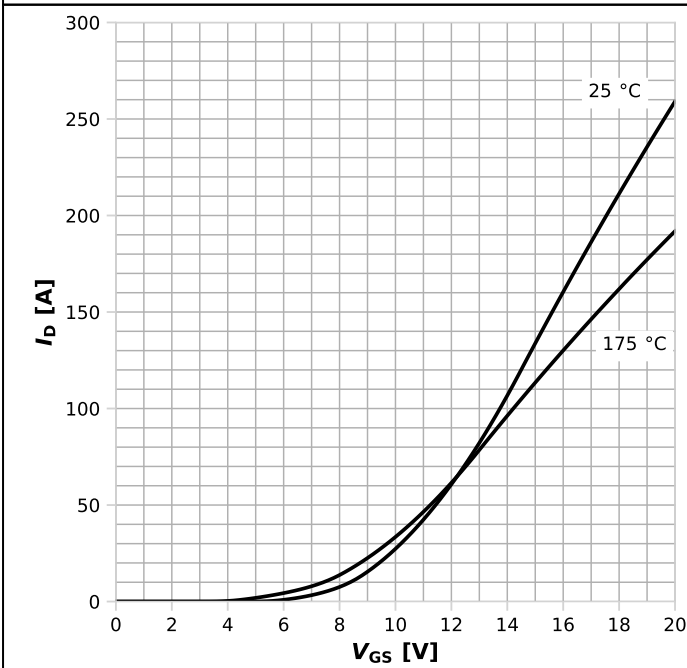
$R_{DS(on)}=f(T_j), I_D=11.1\text{ A}, V_{GS}=18\text{ V}$

Diagram 10: Typ. gate threshold voltage



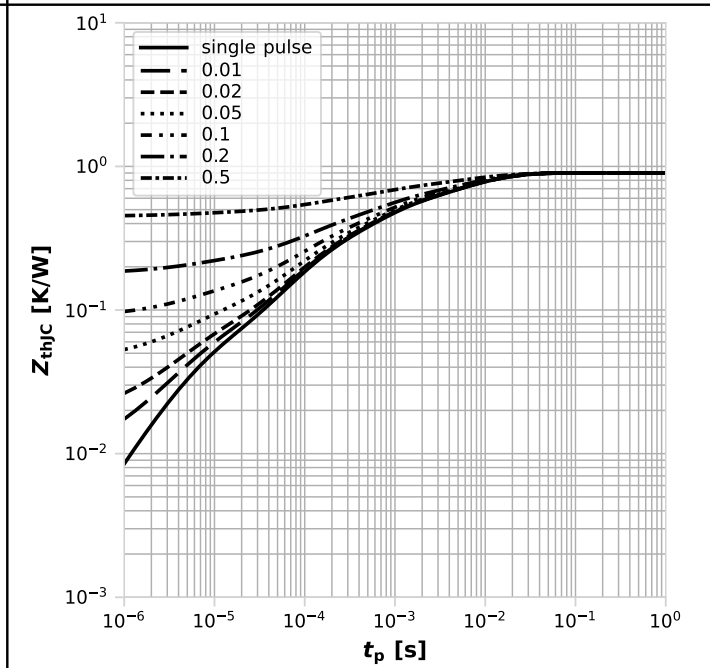
$V_{GS(th)}=f(T_j), V_{GS}=V_{DS}, I_D=4\text{ mA}$

Diagram 11: Typ. transfer characteristics



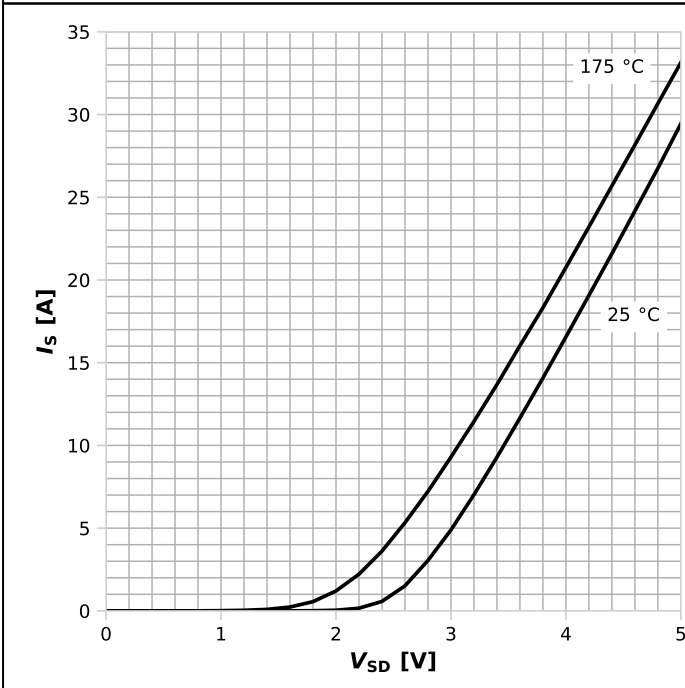
$I_D=f(V_{GS}), |V_{DS}|>2|I_D|R_{DS(on)max}; \text{parameter: } T_j$

Diagram 12: Max. transient thermal impedance



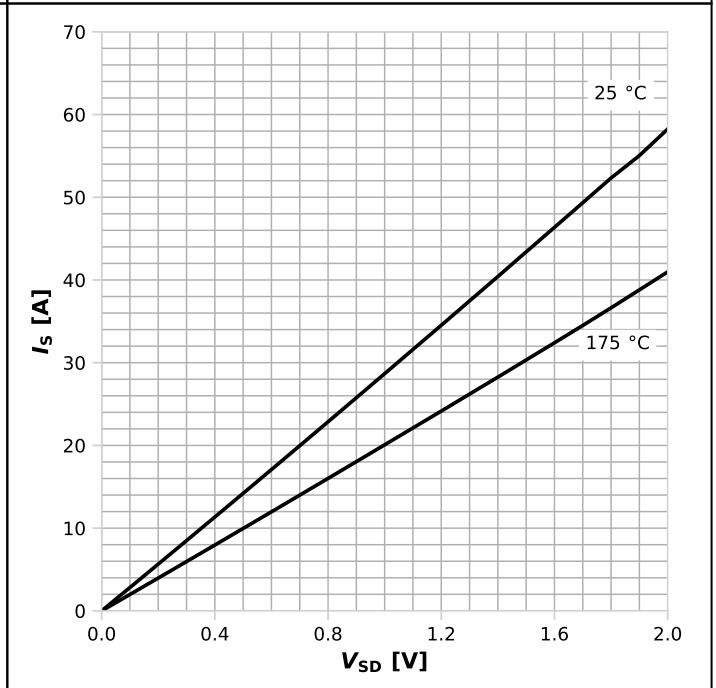
$Z_{thJC}=f(t_p); \text{parameter: } D=t_p/T$

Diagram 13: Reverse output characteristics



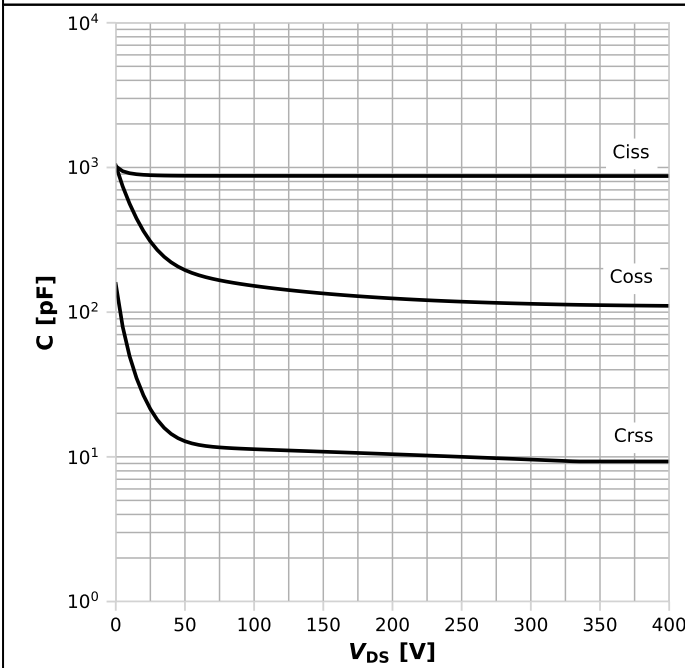
$I_F=f(V_{SD}), V_{GS}=0\text{ V}; \text{parameter: } T_j$

Diagram 14: Reverse output characteristics



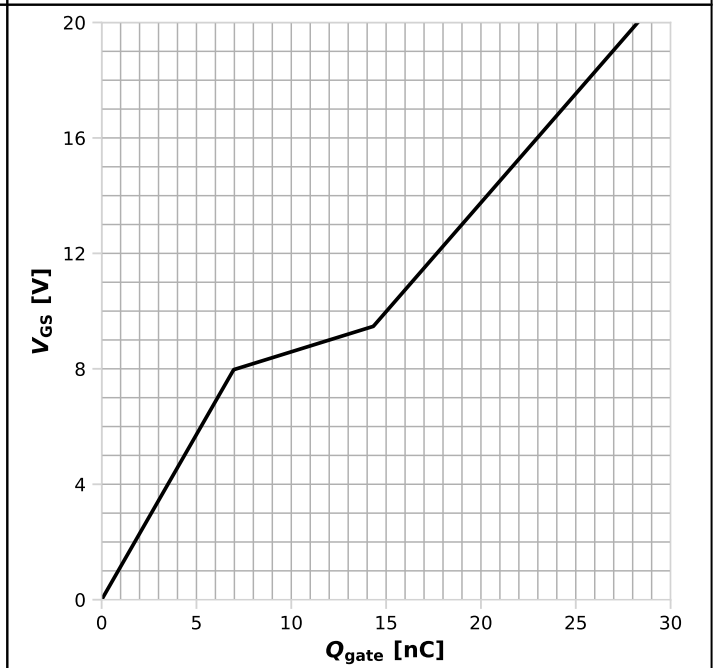
$I_F=f(V_{SD}), V_{GS}=18\text{ V}; \text{parameter: } T_j$

Diagram 15: Typ. capacitances



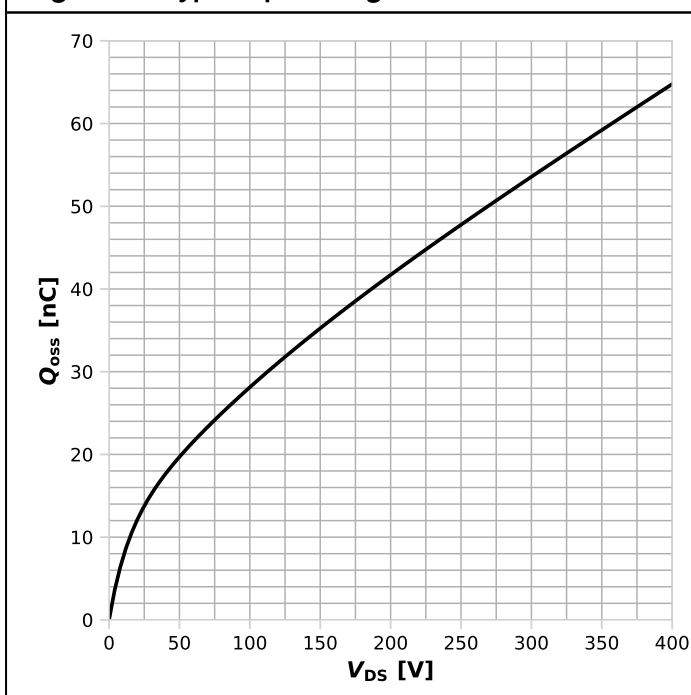
$C=f(V_{DS}); V_{GS}=0\text{ V}; f=1\text{ MHz}$

Diagram 16: Typ. gate charge



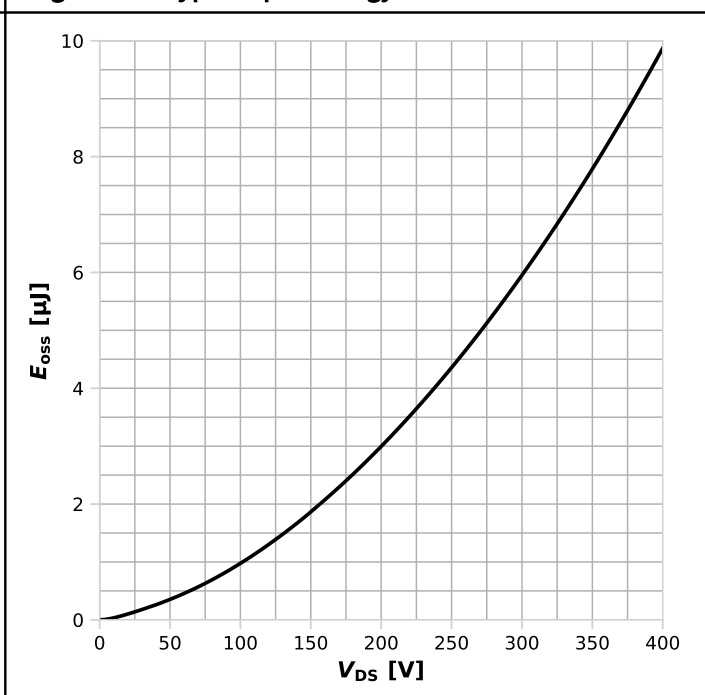
$V_{GS}=f(Q_{gate}), V_{DD}=200\text{ V}, I_D=11.1\text{ A pulsed}, T_j=25\text{ °C}$

Diagram 17: Typ. output charge



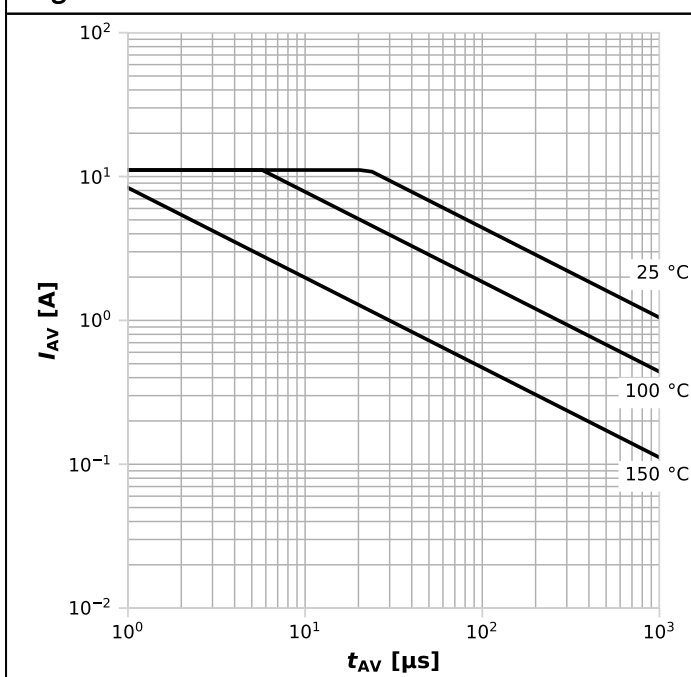
$Q_{oss}=f(V_{DS}), V_{GS}=0\text{ V}$

Diagram 18: Typ. output energy



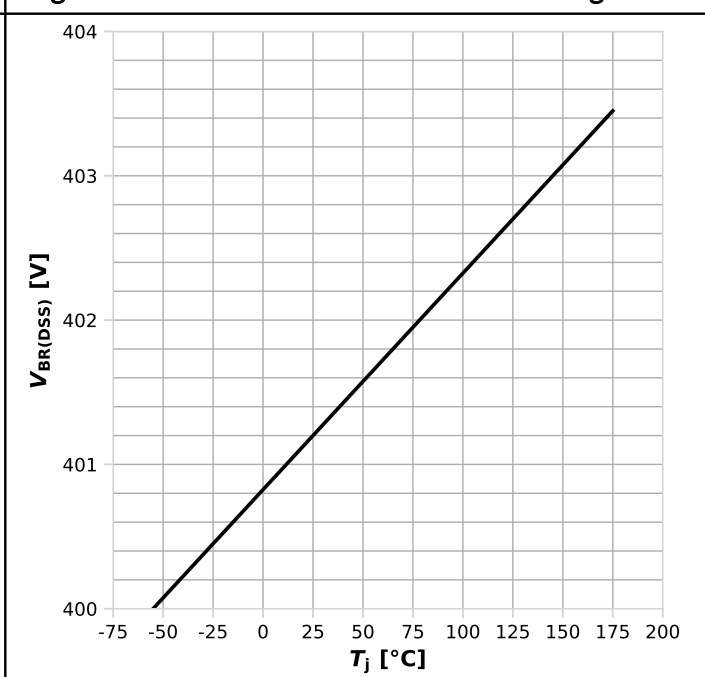
$E_{oss}=f(V_{DS}), V_{GS}=0\text{ V}$

Diagram 19: Avalanche characteristics



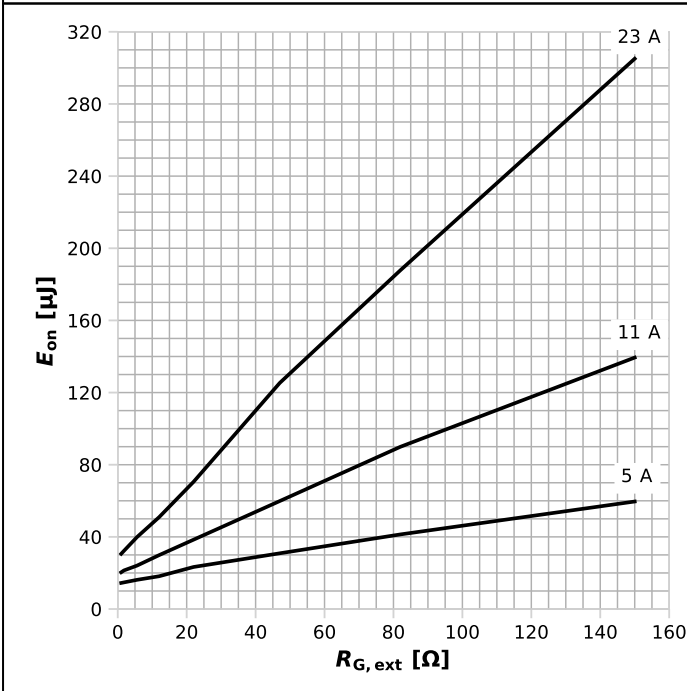
$I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega; \text{parameter: } T_{j,\text{start}}$

Diagram 20: Min. drain-source breakdown voltage



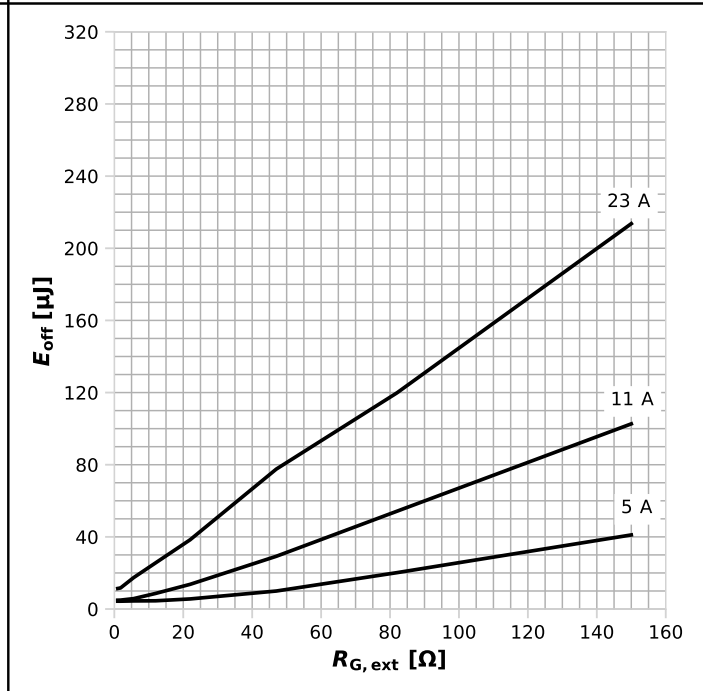
$V_{BR(DSS)}=f(T_j); I_D=0.4\text{ mA}$

Diagram 21: Typ. turn-on switching losses



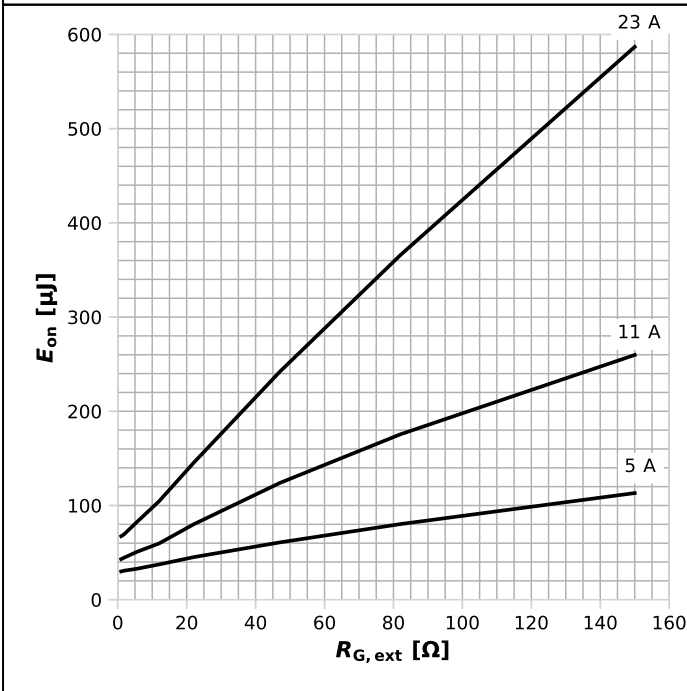
$E_{on}=f(R_{G,ext}), V_{DD}=200\text{ V}, V_G=0\dots 18\text{ V};$ parameter: I_D

Diagram 22: Typ. turn-off switching losses



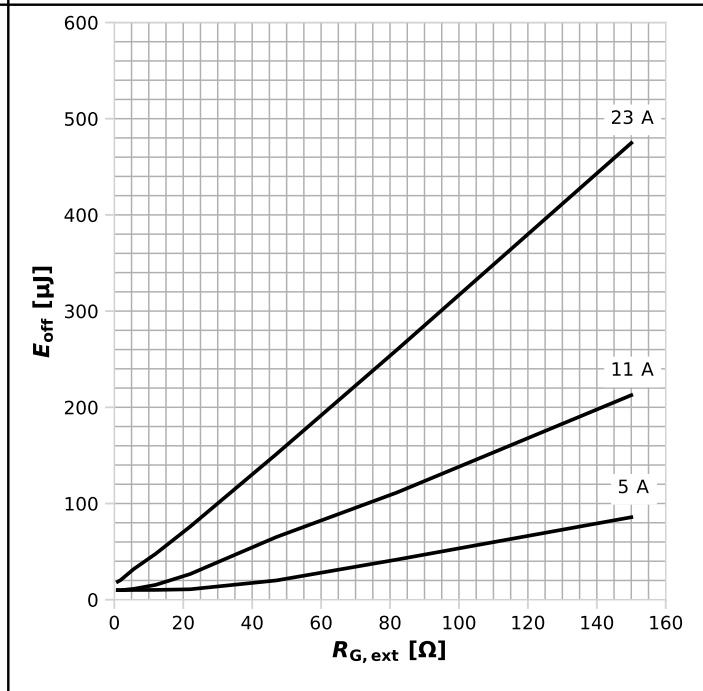
$E_{off}=f(R_{G,ext}), V_{DD}=200\text{ V}, V_G=18\dots 0\text{ V};$ parameter: I_D

Diagram 23: Typ. turn-on switching losses



$E_{on}=f(R_{G,ext}), V_{DD}=320\text{ V}, V_G=0\dots 18\text{ V};$ parameter: I_D

Diagram 24: Typ. turn-off switching losses



$E_{off}=f(R_{G,ext}), V_{DD}=320\text{ V}, V_G=18\dots 0\text{ V};$ parameter: I_D

6 Test Circuits

Table 9 Switching times (CoolSiC)

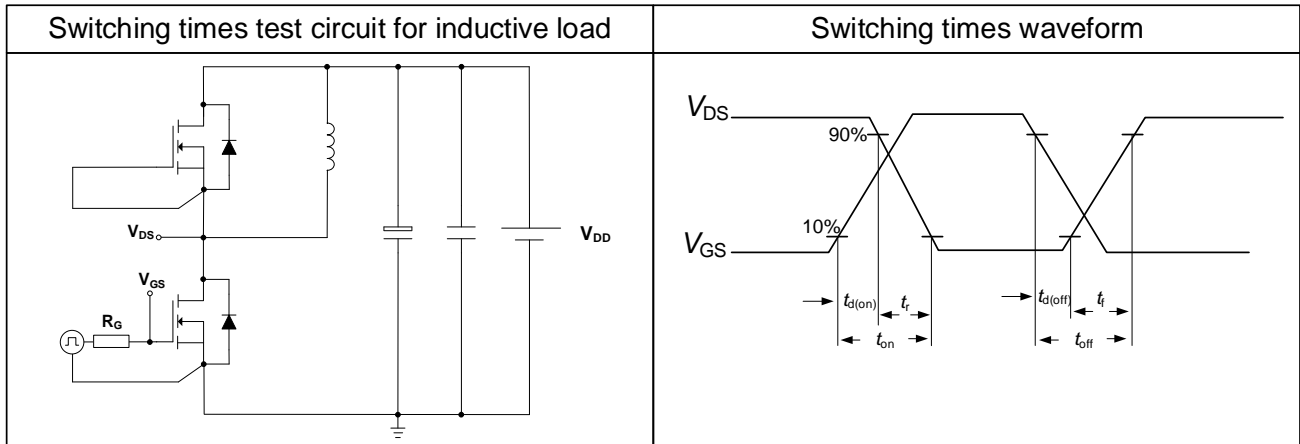
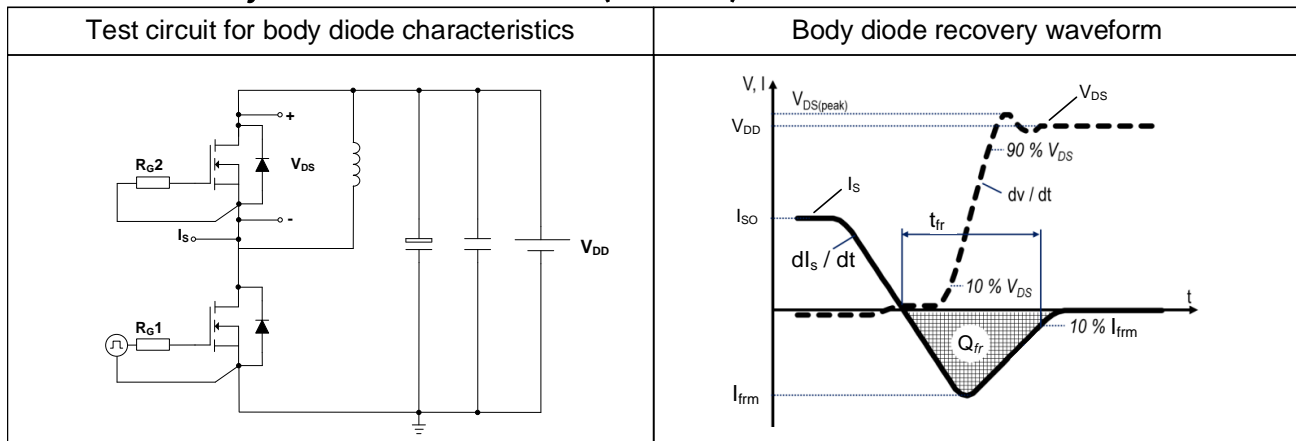
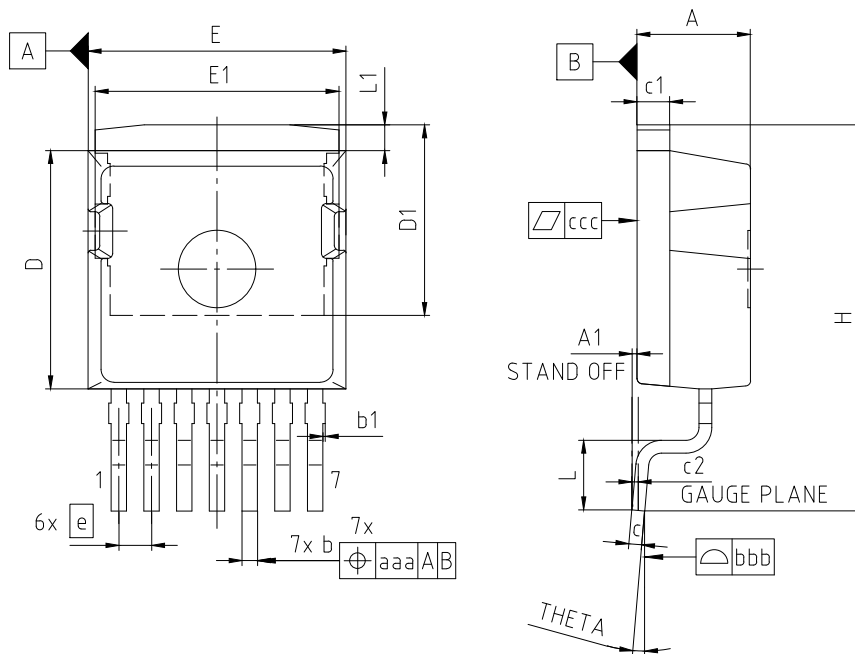


Table 10 Body diode characteristics (CoolSiC)



7 Package Outlines



NOTES:
 ALL METAL SURFACES TIN PLATED EXCEPT AREA OF CUT

PACKAGE - GROUP NUMBER: PG-T0263-7-U04		DIMENSIONS		MILLIMETERS	
DIMENSIONS	MILLIMETERS		DIMENSIONS	MILLIMETERS	
	MIN.	MAX.		MIN.	MAX.
A	4.30	4.50	E1	9.46	
A1	0.00	0.10	e	1.27	
b	0.50	0.70	N	7	
b1	0.00	0.15	H	15.00	
c	0.40	0.60	L	2.50	2.90
c1	1.17	1.37	L1	0.70	1.30
c2	0.25		THETA	---	8.00°
D	9.05	9.45	aaa	0.25	
D1	7.30	7.50	bbb	0.10	
E	9.80	10.20	ccc	0.05	

Figure 1 Outline PG-T0263-7, dimensions in mm

Revision History

IMBG40R036M2H

Revision 2024-04-27, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)
1.0	2024-04-26	Release of preliminary version
2.0	2024-04-27	Release of final

Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

We Listen to Your Comments Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: erratum@infineon.com

Published by

Infineon Technologies AG
81726 München, Germany
© 2024 Infineon Technologies AG
All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.